

# 74AVC16374-Q100

16-bit edge triggered D-type flip-flop; 3.6 V tolerant; 3-state

Rev. 1 — 16 September 2013

Product data sheet

## 1. General description

The 74AVC16374-Q100 is a 16-bit edge triggered flip-flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus-oriented applications. The 74AVC16374-Q100 consist of 2 sections of 8 edge-triggered flip-flops. A clock input (CP) and an output enable ( $\overline{OE}$ ) are provided per 8-bit section.

The 74AVC16374-Q100 is designed to have an extremely fast propagation delay and a minimum amount of power consumption.

To ensure the high-impedance output state during power-up or power-down,  $\overline{OE}$  should be tied to VCC through a pull-up resistor (Live Insertion).

A Dynamic Controlled Output (DCO) circuitry is implemented to support termination line drive during transient (see [Figure 5](#) and [Figure 6](#)).

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 3) and is suitable for use in automotive applications.

## 2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 3)
  - ◆ Specified from  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$
- Wide supply voltage range from 1.2 V to 3.6 V
- Complies with JEDEC standards:
  - ◆ JESD8-7 (1.2 V to 1.95 V)
  - ◆ JESD8-5 (1.8 V to 2.7 V)
  - ◆ JESD8-1A (2.7 V to 3.6 V)
- ESD protection:
  - ◆ MIL-STD-883, method 3015 exceeds 2000 V
  - ◆ HBM JESD22-A114F exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V ( $C = 200 \text{ pF}$ ,  $R = 0 \Omega$ )
- CMOS low power consumption
- Input/output tolerant up to 3.6 V
- Dynamic Controlled Output (DCO) circuit dynamically changes output impedance, resulting in noise reduction without speed degradation
- Low inductance multiple  $V_{\text{CC}}$  and GND pins to minimize noise and ground bounce
- Supports Live Insertion



### 3. Ordering information

Table 1. Ordering information

Type number	Package	Temperature range	Name	Description	Version
74AVC16374DGG-Q100	TSSOP48	−40 °C to +85 °C		plastic thin shrink small outline package; 48 leads; body width 6.1 mm	SOT362-1

### 4. Functional diagram

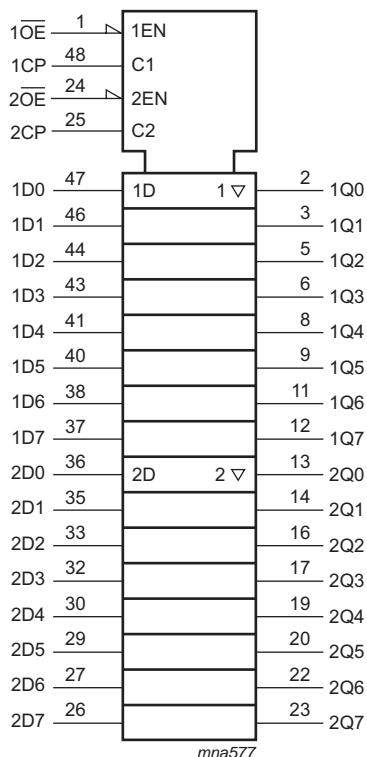


Fig 1. IEC logic symbol

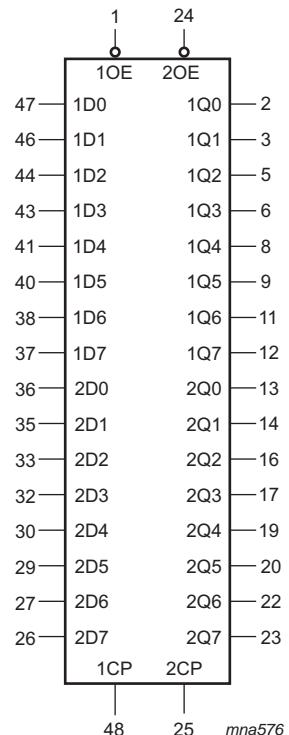


Fig 2. Logic symbol

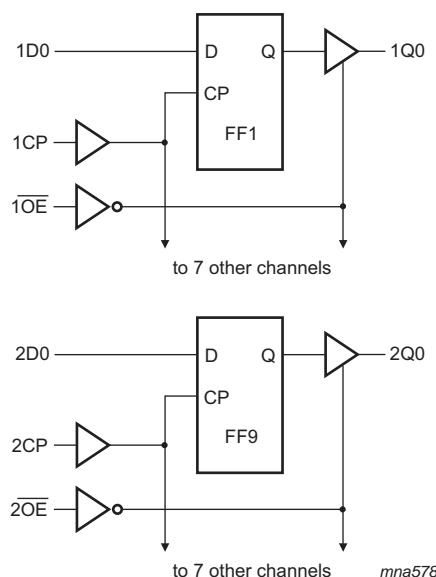


Fig 3. Logic diagram

## 5. Pinning information

### 5.1 Pinning

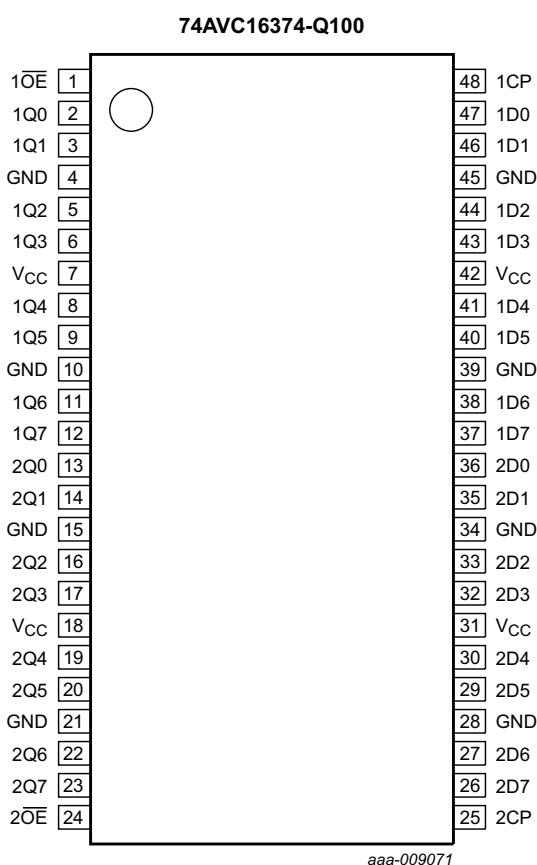


Fig 4. Pin configuration

### 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
1OE	1	output enable input (active LOW)
1Q0 to 1Q7	2, 3, 5, 6, 8, 9, 11, 12	3-state flip-flop outputs
GND	4, 10, 15, 21, 28, 34, 39, 45	ground (0 V)
V <sub>CC</sub>	7, 18, 31, 42	supply voltage
2Q0 to 2Q7	13, 14, 16, 17, 19, 20, 22, 23	3-state flip-flop outputs
2OE	24	output enable input (active LOW)
2CP	25	clock input
2D0 to 2D7	36, 35, 33, 32, 30, 29, 27, 26	data input/output
1D0 to 1D7	47, 46, 44, 43, 41, 40, 38, 37	data input/output
1CP	48	clock input

## 6. Functional description

Table 3. Function table<sup>[1]</sup>

Operating modes	Inputs			Internal flip-flops	Outputs
	nOE	nCp	nDn		
Load and read register	L	↑	I	L	L
	L	↑	h	H	H
Load register and disable outputs	H	↑	I	L	Z
	H	↑	h	H	Z

[1] H = HIGH voltage level  
h = HIGH voltage level one set-up time prior to the LOW-to-HIGH CP transition  
L = LOW voltage level  
I = LOW voltage level one set-up time prior to the LOW-to-HIGH CP transition  
Z = high-impedance OFF-state  
↑ = LOW-to-HIGH CP transition

## 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+4.6	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V	-	-50	mA
V <sub>I</sub>	input voltage		<sup>[1]</sup> -0.5	+4.6	V
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V	-50	-	mA
V <sub>O</sub>	output voltage	output HIGH or LOW	<sup>[1]</sup> -0.5	V <sub>CC</sub> + 0.5	V
		output 3-state	<sup>[1]</sup> -0.5	+4.6	V
I <sub>O</sub>	output current	V <sub>O</sub> = 0 V to V <sub>CC</sub>	-	±50	mA
I <sub>CC</sub>	supply current		-	+100	mA
I <sub>GND</sub>	ground current		-100	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +85 °C	<sup>[2]</sup> -	500	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] Above 60 °C, the value of P<sub>tot</sub> derates linearly with 5.5 mW/K.

## 8. Recommended operating conditions

**Table 5. Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V <sub>CC</sub>	supply voltage	according to JEDEC Low Voltage Standards	1.4	-	1.6	V
			1.65	-	1.95	V
			2.3	-	2.7	V
			3.0	-	3.6	V
V <sub>I</sub>	input voltage	for low-voltage applications	1.2	-	3.6	V
			0	-	3.6	V
V <sub>O</sub>	output voltage	output HIGH or LOW	0	-	V <sub>CC</sub>	V
		output 3-state	0	-	3.6	V
T <sub>amb</sub>	ambient temperature	in free air	-40	-	+85	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 1.4 V to 1.6 V	0	-	40	ns/V
		V <sub>CC</sub> = 1.65 V to 2.3 V	0	-	30	ns/V
		V <sub>CC</sub> = 2.3 V to 3.0 V	0	-	20	ns/V
		V <sub>CC</sub> = 3.0 V to 3.6 V	0	-	10	ns/V

## 9. Static characteristics

**Table 6. Static characteristics**

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
<b>T<sub>amb</sub> = -40 °C to +85 °C</b>						
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 1.2 V	V <sub>CC</sub>	-	-	V
		V <sub>CC</sub> = 1.4 V to 1.6 V	0.65 × V <sub>CC</sub>	0.9	-	V
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 × V <sub>CC</sub>	0.9	-	V
		V <sub>CC</sub> = 2.3 V to 2.7 V	1.7	1.2	-	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	2.0	1.5	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 1.2 V	-	-	GND	V
		V <sub>CC</sub> = 1.4 V to 1.6 V	-	0.9	0.35 × V <sub>CC</sub>	V
		V <sub>CC</sub> = 1.65 V to 1.95 V	-	0.9	0.35 × V <sub>CC</sub>	V
		V <sub>CC</sub> = 2.3 V to 2.7 V	-	1.2	0.7	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	-	1.5	0.8	V
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>				
		I <sub>O</sub> = -100 μA; V <sub>CC</sub> = 1.65 V to 3.6 V	V <sub>CC</sub> - 0.20	V <sub>CC</sub>	-	V
		I <sub>O</sub> = -3 mA; V <sub>CC</sub> = 1.4 V	V <sub>CC</sub> - 0.35	V <sub>CC</sub> - 0.23	-	V
		I <sub>O</sub> = -4 mA; V <sub>CC</sub> = 1.65 V	V <sub>CC</sub> - 0.45	V <sub>CC</sub> - 0.25	-	V
		I <sub>O</sub> = -8 mA; V <sub>CC</sub> = 2.3 V	V <sub>CC</sub> - 0.55	V <sub>CC</sub> - 0.38	-	V
		I <sub>O</sub> = -12 mA; V <sub>CC</sub> = 3.0 V	V <sub>CC</sub> - 0.70	V <sub>CC</sub> - 0.48	-	V

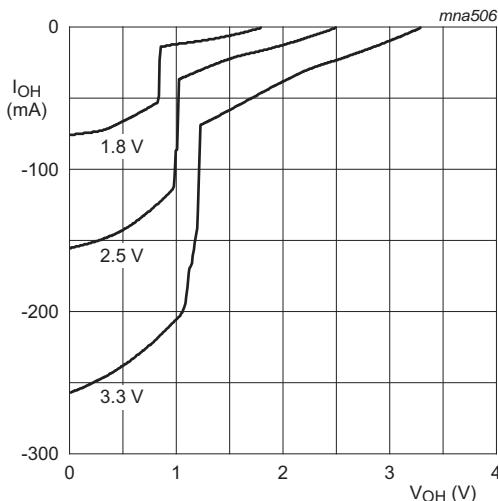
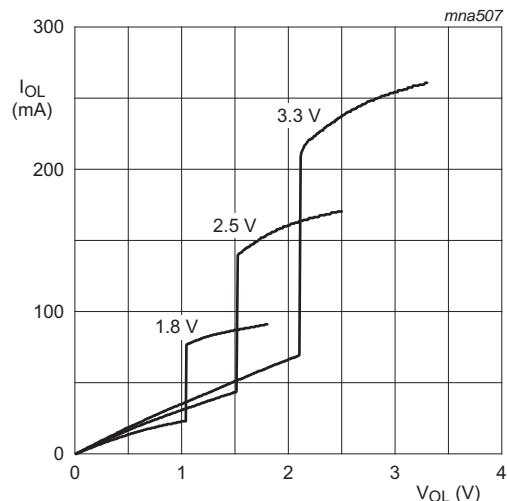
**Table 6. Static characteristics ...continued**

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Typ <sup>[1]</sup>	Max	Unit
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>				
		I <sub>O</sub> = 100 $\mu$ A; V <sub>CC</sub> = 1.65 V to 3.6 V	-	GND	0.20	V
		I <sub>O</sub> = 3 mA; V <sub>CC</sub> = 1.4 V	-	0.10	0.35	V
		I <sub>O</sub> = 4 mA; V <sub>CC</sub> = 1.65 V	-	0.10	0.45	V
		I <sub>O</sub> = 8 mA; V <sub>CC</sub> = 2.3 V	-	0.26	0.55	V
		I <sub>O</sub> = 12 mA; V <sub>CC</sub> = 3.0 V	-	0.36	0.70	V
I <sub>I</sub>	input leakage current	per pin; V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 1.4 V to 3.6 V	-	0.1	2.5	$\mu$ A
I <sub>OFF</sub>	power-off leakage current	V <sub>I</sub> or V <sub>O</sub> = 3.6 V; V <sub>CC</sub> = 0.0 V	-	$\pm$ 0.1	$\pm$ 10	$\mu$ A
I <sub>OZ</sub>	OFF-state output current	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>O</sub> = V <sub>CC</sub> or GND				
		V <sub>CC</sub> = 1.4 V to 2.7 V	-	0.1	5	$\mu$ A
		V <sub>CC</sub> = 3.0 V to 3.6 V	-	0.1	10	$\mu$ A
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A				
		V <sub>CC</sub> = 1.4 V to 2.7 V	-	0.1	20	$\mu$ A
		V <sub>CC</sub> = 3.0 V to 3.6 V	-	0.2	40	$\mu$ A
C <sub>I</sub>	input capacitance		-	5	-	pF

[1] All typical values are measured at T<sub>amb</sub> = 25 °C.

## 9.1 Graphs

**Fig 5. Output voltage as a function of the HIGH-level output current.****Fig 6. Output voltage as a function of the LOW-level output current.**

## 10. Dynamic characteristics

**Table 7. Dynamic characteristics**

Voltages are referenced to GND (ground = 0 V).  $t_r = t_f \leq 2$  ns. For test circuit, see [Figure 10](#).

Symbol	Parameter	Conditions	-40 °C to +85 °C			Unit
			Min	Typ <sup>[2]</sup>	Max	
$t_{pd}$	propagation delay	nCP to nQn; see <a href="#">Figure 7</a>	[1]			
		$V_{CC} = 1.2$ V	-	3.1	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	1.2	2.4	8.4	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.0	2.0	6.7	ns
		$V_{CC} = 2.3$ V to 2.7 V	0.8	1.5	4.1	ns
		$V_{CC} = 3.0$ V to 3.6 V	0.7	1.3	3.3	ns
$t_{en}$	enable time	$\overline{nOE}$ to nQn, nBn; see <a href="#">Figure 8</a>	[1]			
		$V_{CC} = 1.2$ V	-	5.4	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	1.6	3.9	8.5	ns
		$V_{CC} = 1.65$ V to 1.95 V	2.3	3.3	6.7	ns
		$V_{CC} = 2.3$ V to 2.7 V	0.9	2.3	4.3	ns
		$V_{CC} = 3.0$ V to 3.6 V	0.7	2.0	3.4	ns
$t_{dis}$	disable time	$\overline{nOE}$ to nQn; see <a href="#">Figure 8</a>	[1]			
		$V_{CC} = 1.2$ V	-	5.6	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	2.5	4.5	9.4	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.8	3.3	7.8	ns
		$V_{CC} = 2.3$ V to 2.7 V	1.0	1.8	4.2	ns
		$V_{CC} = 3.0$ V to 3.6 V	1.2	2.0	3.9	ns
$t_w$	pulse width	HIGH; nCP; see <a href="#">Figure 7</a>				
		$V_{CC} = 1.2$ V	-	0.8	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	-	0.5	-	ns
		$V_{CC} = 1.65$ V to 1.95 V	3.1	0.3	-	ns
		$V_{CC} = 2.3$ V to 2.7 V	2.5	0.2	-	ns
		$V_{CC} = 3.0$ V to 3.6 V	2.5	0.2	-	ns
$t_{su}$	set-up time	nDn to nCP; see <a href="#">Figure 8</a>				
		$V_{CC} = 1.2$ V	-	-0.6	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	2.7	-0.3	-	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.9	-0.3	-	ns
		$V_{CC} = 2.3$ V to 2.7 V	1.4	-0.2	-	ns
		$V_{CC} = 3.0$ V to 3.6 V	1.4	-0.1	-	ns
$t_h$	hold time	nDn to nCP; see <a href="#">Figure 8</a>				
		$V_{CC} = 1.2$ V	-	0.8	-	ns
		$V_{CC} = 1.4$ V to 1.6 V	1.3	0.7	-	ns
		$V_{CC} = 1.65$ V to 1.95 V	1.2	0.6	-	ns
		$V_{CC} = 2.3$ V to 2.7 V	1.1	0.5	-	ns
		$V_{CC} = 3.0$ V to 3.6 V	1.1	0.4	-	ns

**Table 7. Dynamic characteristics ...continued**Voltages are referenced to GND (ground = 0 V).  $t_r = t_f \leq 2$  ns. For test circuit, see [Figure 10](#).

Symbol	Parameter	Conditions	-40 °C to +85 °C			Unit
			Min	Typ <sup>[2]</sup>	Max	
$f_{max}$	maximum frequency	see <a href="#">Figure 8</a>				
		$V_{CC} = 1.2$ V	-	250	-	MHz
		$V_{CC} = 1.4$ V to 1.6 V	-	300	-	MHz
		$V_{CC} = 1.65$ V to 1.95 V	160	320	-	MHz
		$V_{CC} = 2.3$ V to 2.7 V	200	350	-	MHz
		$V_{CC} = 3.0$ V to 3.6 V	200	350	-	MHz
$C_{PD}$	power dissipation capacitance	per input; $V_I = \text{GND}$ to $V_{CC}$	<sup>[3]</sup>			
		outputs enabled	-	66	-	pF
		outputs disabled	-	1	-	pF

[1]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ . $t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ . $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .[2] Typical values are measured at  $T_{amb} = 25$  °C and  $V_{CC} = 1.2$  V, 1.5 V, 1.8 V, 2.5 V and 3.3 V respectively.[3]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ ).

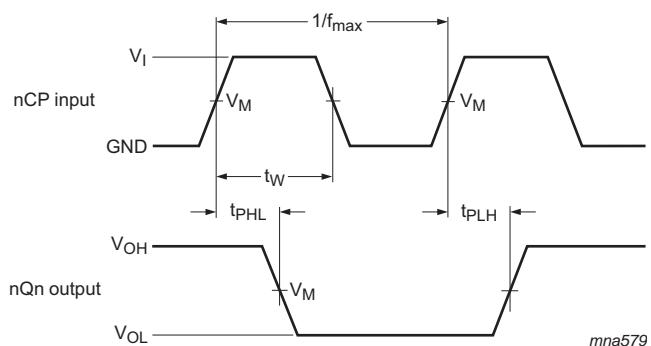
$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \sum(C_L \times V_{CC}^2 \times f_o)$$

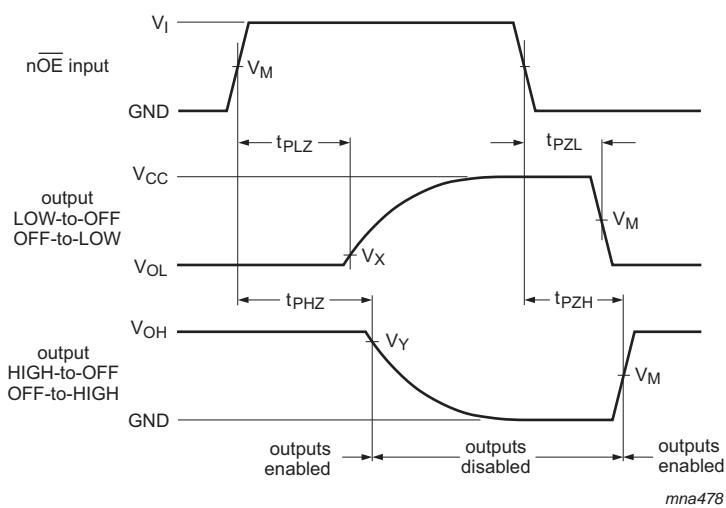
 $f_i$  = input frequency in MHz;  $f_o$  = output frequency in MHz $C_L$  = output load capacitance in pF $V_{CC}$  = supply voltage in Volts

N = number of inputs switching

 $\sum(C_L \times V_{CC}^2 \times f_o)$  = sum of the outputs.

## 11. Waveforms

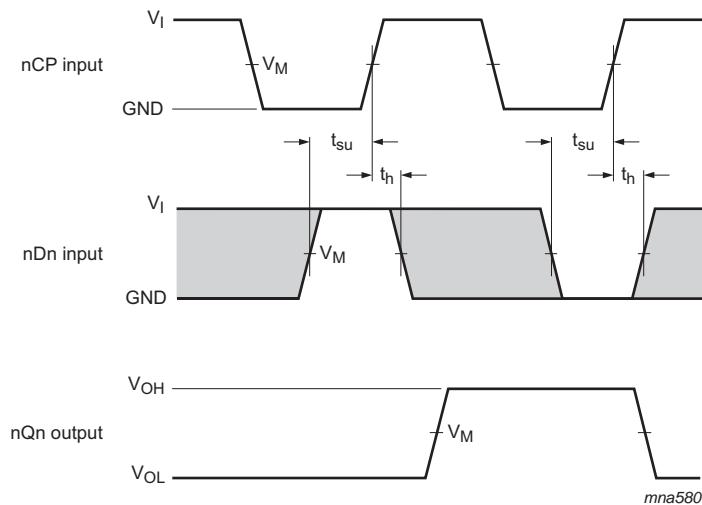
Measurement points are given in [Table 9](#).Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.**Fig 7. Clock input (nCP) to output (nQn) propagation delays**



Measurement points are given in [Table 9](#).

Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 8. 3-state enable and disable times**



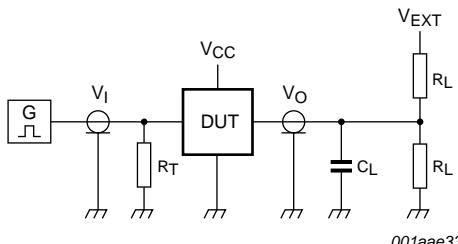
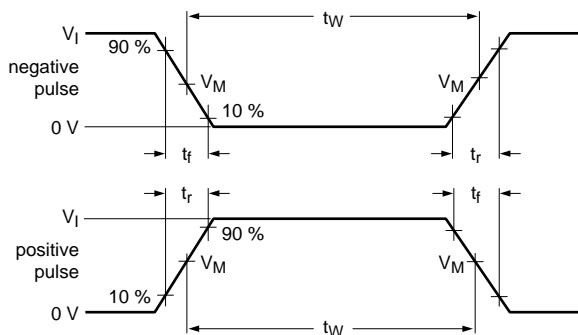
Measurement points are given in [Table 9](#).

Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 9. Data set-up and hold times for  $nDn$  input to  $nCP$  input**

Table 8. Measurement points

Supply voltage	V <sub>M</sub>	Input			
		V <sub>I</sub>	t <sub>r</sub> = t <sub>f</sub>	V <sub>X</sub>	V <sub>Y</sub>
1.2 V	0.5 × V <sub>CC</sub>	V <sub>CC</sub>	≤ 2 ns	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V
1.4 V to 1.6 V	0.5 × V <sub>CC</sub>	V <sub>CC</sub>	≤ 2 ns	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V
1.65 V to 1.95 V	0.5 × V <sub>CC</sub>	V <sub>CC</sub>	≤ 2 ns	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V
2.3 V to 2.7 V	0.5 × V <sub>CC</sub>	V <sub>CC</sub>	≤ 2 ns	V <sub>OL</sub> + 0.15 V	V <sub>OH</sub> - 0.15 V
3.0 V to 3.6 V	0.5 × V <sub>CC</sub>	V <sub>CC</sub>	≤ 2 ns	V <sub>OL</sub> + 0.3 V	V <sub>OH</sub> - 0.3 V



Test data is given in [Table 9](#).

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

C<sub>L</sub> = Load capacitance including jig and probe capacitance.

R<sub>T</sub> = Termination resistance should be equal to output impedance Z<sub>o</sub> of the pulse generator.

V<sub>EXT</sub> = External voltage for measuring switching times.

Fig 10. Test circuit for measuring switching times

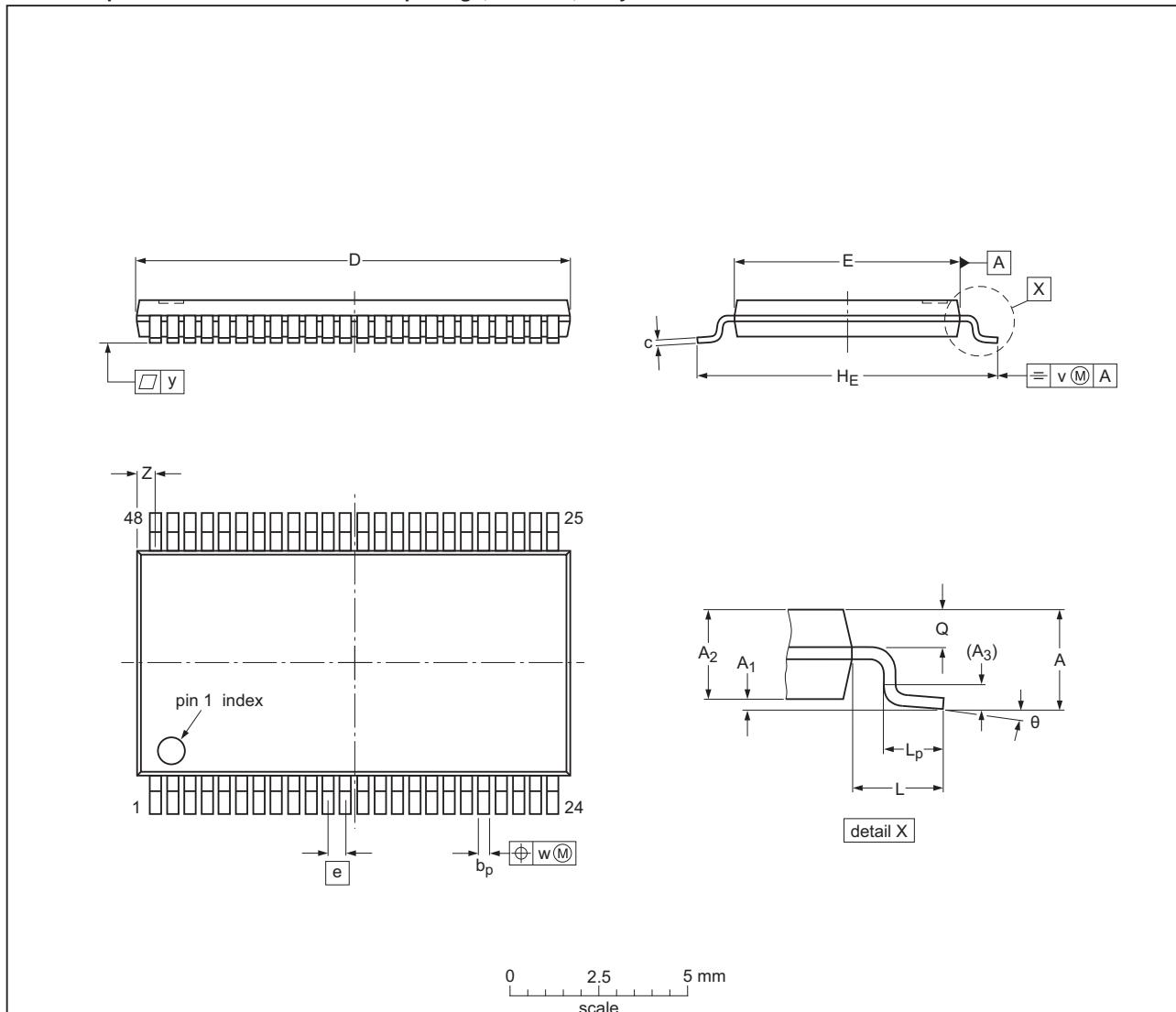
Table 9. Test data

Supply voltage	Input		Load		V <sub>EXT</sub>		
	V <sub>I</sub>	t <sub>r</sub> , t <sub>f</sub>	C <sub>L</sub>	R <sub>L</sub>	t <sub>PLH</sub> , t <sub>PHL</sub>	t <sub>PZL</sub> , t <sub>PZL</sub>	t <sub>PHZ</sub> , t <sub>PZH</sub>
1.2 V	V <sub>CC</sub>	≤ 2 ns	15 pF	2 kΩ	open	2 × V <sub>CC</sub>	GND
1.4 V to 1.6 V	V <sub>CC</sub>	≤ 2 ns	15 pF	2 kΩ	open	2 × V <sub>CC</sub>	GND
1.65 V to 1.95 V	V <sub>CC</sub>	≤ 2 ns	30 pF	1 kΩ	open	2 × V <sub>CC</sub>	GND
2.3 V to 2.7 V	V <sub>CC</sub>	≤ 2 ns	30 pF	500 Ω	open	2 × V <sub>CC</sub>	GND
3.0 V to 3.6 V	V <sub>CC</sub>	≤ 2 ns	30 pF	500 Ω	open	2 × V <sub>CC</sub>	GND

## 12. Package outline

TSSOP48: plastic thin shrink small outline package; 48 leads; body width 6.1 mm

SOT362-1



Dimensions (mm are the original dimensions)

Unit	A	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	b <sub>p</sub>	c	D <sup>(1)</sup>	E <sup>(2)</sup>	e	H <sub>E</sub>	L	L <sub>p</sub>	Q	v	w	y	Z	θ
mm	max	0.15	1.05		0.28	0.2	12.6	6.2		8.3		0.8	0.50			0.8	8°	
mm	nom	1.2		0.25					0.5		1			0.25	0.08	0.1		
mm	min	0.05	0.85		0.17	0.1	12.4	6.0		7.9		0.4	0.35			0.4	0°	

Note

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

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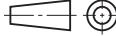
Outline version	References				European projection	Issue date
	IEC	JEDEC	JEITA			
SOT362-1		MO-153				03-02-19- 13-08-05

Fig 11. Package outline SOT362-1 (TSSOP48)

## 13. Abbreviations

**Table 10. Abbreviations**

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
MIL	Military
TTL	Transistor-Transistor Logic

## 14. Revision history

**Table 11. Revision history**

Document ID	Release date	Data sheet status	Change notice	Order number	Supersedes
74AVC16374_Q100 v.1	20130916	Product data sheet	-	-	-

## 15. Legal information

### 15.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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